

## Notice of References Cited

	, , , , , , , , , , , , , , , , , , ,		
1	Application/Control No.	Applicant(s)/Pater	nt Under
	09/937,470	Reexamination ECKEL ET AL.	
ı	Examiner	Art Unit	
	Peter Szekely	1714	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,672,645	09-1997	Eckel et al.	524/127
	В	US-5,750,602	05-1998	Kohler et al.	524/127
	С	US-5,994,463	11-1999	Eckel et al.	525/67
	D	US-6,083,428	07-2000	Ueda et al.	252/609
	Ε	US-6,326,423	12-2001	Eckel et al.	524/117
	F	US-6,414,107	07-2002	Zobel et al.	528/196
	G	US-6,441,068	08-2002	Eckel et al.	524/127
	Н	US-2002/0072553	06-2002	ECKEL et al.	524/127
	ı	US-			
	٦	US-			
	к	US-			
	L	US-			
	М	US-	:		

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 197 21 628	11-1998	Germany	Bayer	
	0	DE 197 34 667	02-1999	Germany	Bayer	
	Р	DE 198 01 050	07-1999	Germany	Bayer	
	a	DE 198 56 484	06-2000	Germany	Bayer	
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.